TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MZ244FK

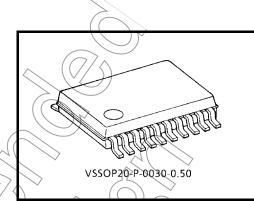
Low Voltage Octal Bus Buffer with 5 V Tolerant Inputs and Outputs

The TC7MZ244FK is a high performance CMOS octal bus buffer. Designed for use in $3.3~\rm V$ systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5 V supply environment for both inputs and outputs.

The TC7MZ244FK is a non-inverting 3-state buffer having two active-low output enables. This device is designed to be used with 3-state memory address drivers, etc.

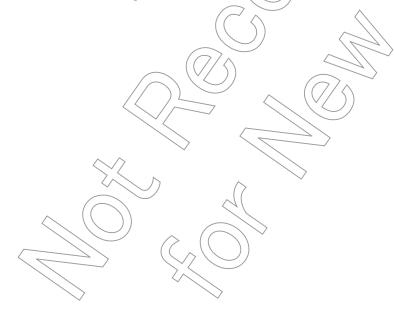
All inputs are equipped with protection circuits against static discharge.



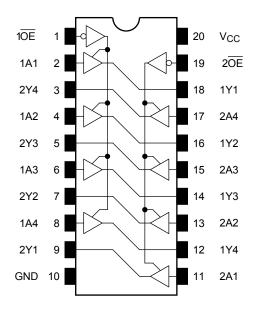
Weight: 0.03 g (typ.)

Features

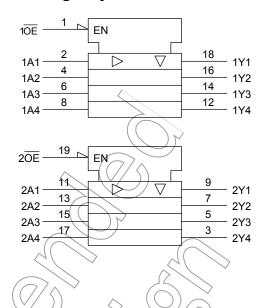
- Low voltage operation: $V_{CC} = 2.0 \sim 3.6 \text{ V}$
- High speed operation: $t_{pd} = 6.5 \text{ ns (max)} (V_{CC} = 3.0 \sim 3.6 \text{ V})$
- Output current: | I_{OH} | /I_{OL} = 24 mA (min) (V_{CC} = 3.0 V)
- Latch-up performance: -500 mA
- Package: VSSOP (US20)
- Power down protection is provided on all inputs and outputs.
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 244 type.



Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Inp	uts	Outputs
ŌĒ	An	Outputs
L	L	L
L	Н	Н
Н	Х	Z

- X: Don't care
- Z: High impedance

Absolute Maximum Ratings (Note 1)

	\sim 2 .		
Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC} <	-0.5~7.0	V
DC input voltage	V _{IN}	-0.5~7.0	V
DC output voltage	Vout	-0.5~7.0 (Note 2)	V
Coulput voltage	V001	-0.5~V _{CC} + 0.5 (Note 3)	V
Input diode current	Ι _{ΙΚ}	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	loni	±50	mA
Power dissipation	(PD)	180	mW
DC Vcc/ground current	ICC/IGND	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 2: Output in off-state
- Note 3: High or low state. IOUT absolute maximum rating must be observed.
- Note 4: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage	Vcc	2.0~3.6	V
Supply voltage	VCC	1.5~3.6 (Note 2)	V
Input voltage	V _{IN}	0~5.5	V
Output voltage	V _{OUT}	0~5.5 (Note 3)	V
Output voltage		0~V _{CC} (Note 4)	V
Output current	IOH/IOI	±24 (Note 5)	mA (
Output current	IOH/IOL	±12 (Note 6)	
Operating temperature	T _{opr}	-40~85	çc
Input rise and fall time	dt/dv	0~10 (Note 7)	ns/V)

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

Note 3: Output in off-state

Note 4: High or low state

Note 5: $V_{CC} = 3.0 \sim 3.6 \text{ V}$

Note 6: $V_{CC} = 2.7 \sim 3.0 \text{ V}$

Note 7: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$

Electrical Characteristics

DC Characteristics (Ta = -40~85°C)

Characteristics S		Symbol				Min	Max	Unit
		Syllide			V _{CC} (V)			
Input voltage	High level	VIH)) (2.7~3.6	2.0	_	V
iliput voltage	Low level	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	, (/	(\mathcal{L})	2.7~3.6	_	0.8	V
		\ \		I _{OH} = -100 μA	2.7~3.6	V _{CC} - 0.2		
	High Jevel	V _{OH}	VIN = VIH or VIL	$I_{OH} = -12 \text{ mA}$	2.7	2.2	_	V
·	ZX n		\sim	$I_{OH} = -18 \text{ mA}$	3.0	2.4	_	
Output voltage/				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	
			I _{OL} = 100 μA	2.7~3.6	_	0.2		
	Lowlovol	$\gamma_{VQL}(($	V or V.	I _{OL} = 12 mA	2.7	_	0.4	
Low level	VOL	VIN VIH or VIL	I _{OL} = 16 mA	3.0	_	0.4		
				I _{OL} = 24 mA	3.0	_	0.55	
Input leakage cu	rrent	I _{IN}	V _{IN} = 0~5.5 V		2.7~3.6	_	±5.0	μΑ
3-state output off-state current I _{OZ}		loz	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \sim 5.5 \text{ V}$		2.7~3.6	_	±5.0	μА
		102			2.7~3.0		±3.0	μΑ
Power off leakag	e current	l _{OFF}	$V_{IN}/V_{OUT} = 5.5 V$		0	_	10.0	μΑ
Quiescent supply current I _C		loo	V _{IN} = V _{CC} or GND		2.7~3.6	_	10.0	
		Icc	V _{IN} /V _{OUT} = 3.6~5.5 V		2.7~3.6	_	±10.0	μΑ
Increase in I _{CC} p	er input	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7~3.6	_	500	

AC Characteristics ($Ta = -40 \sim 85$ °C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.7	_	7.5	- ns
1 Topagation delay time	t _{pHL}	rigate 1, rigate 2	3.3 ± 0.3	1.5	6.5	
Output enable time	t_{pZL}	Figure 1, Figure 3	2.7		9.0	ns
	t _{pZH}		3(3(± 0.3)	1.5	8.0	113
Output disable time	t _{pLZ}	Figure 1, Figure 3	2.7)_	8.0	ns
	t _{pHZ}	rigure 1, rigure 3	3.3 0.3	1.5	7.0	113
Output to output skew	t _{osLH}	(Note)	2.1			ns
	t _{osHL}	(HADIE)	3.3 ± 0.3		1.0	113

Note: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, Input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ Ω

			_ //			
Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V_{OL}	V _{OLP}	$V_{IH} = 3.3 V$, $V_{IL} = 0 V$		3.3	8.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	V _{IH} = 3.3 V, V _{IL} = 0 V		3.3	8.0	٧

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	CIN		3.3	7	pF
Output capacitance	COUT		3.3	8	pF
Power dissipation capacitance	CPD	f _{IN} = 10 MHz (Note)	3.3	25	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

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Average operating current can be obtained by the equation:

ICC (opr) = CPD·VCC·fIN + ICC/8 (per bit)



AC Test Circuit

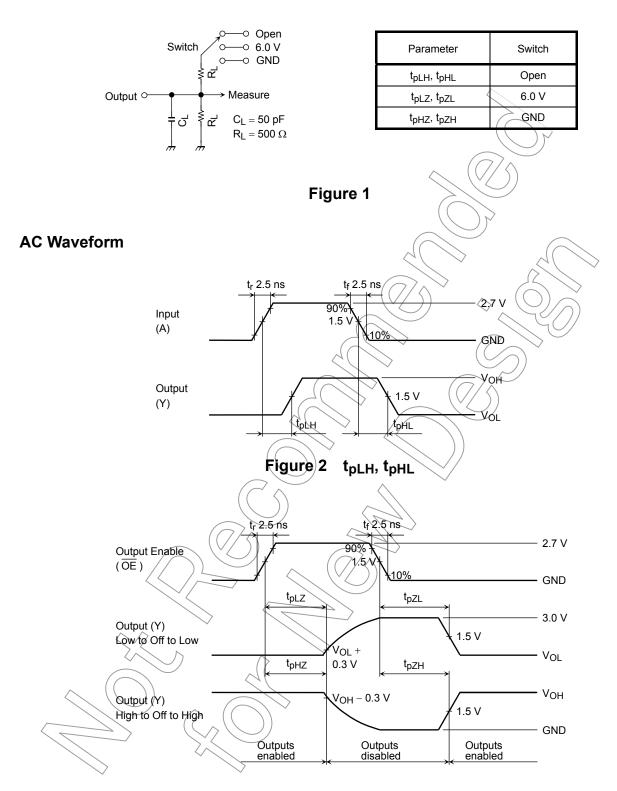
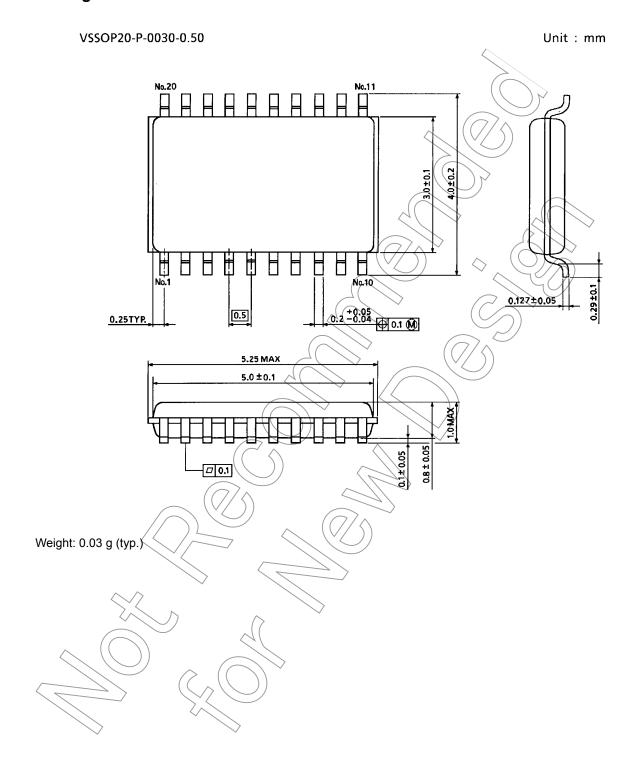


Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

Package Dimensions



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2007-10-19